## Search Notes

| Application/Control No. | Applicant(s)/Patent Under Reexamination |
|-------------------------|---|
| 10617565                | NIE ET AL.                              |
| Examiner                | Art Unit                                |
| Anthony Weier           | 1794                                    |

| SEARCHED |                 |         |          |  |  |  |
|----------|-----------------|---------|----------|--|--|--|
| Class    | Subclass        | Date    | Examiner |  |  |  |
| updated  | previous search | 3/17/08 | AW       |  |  |  |
| updated  | previous search | 1/5/09  | AW       |  |  |  |

| INTERFERENCE SEARCH |          |      |          |  |
|---------------------|----------|------|----------|--|
| Class               | Subclass | Date | Examiner |  |
|                     |          |      |          |  |

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